



ELECTRONICS, INC.  
44 FARRAND STREET  
BLOOMFIELD, NJ 07003  
(973) 748-5089  
<http://www.nteinc.com>

## **NTE5442 thru NTE5448 Silicon Controlled Rectifier (SCR) 8 Amp, TO127**

### **Description:**

The NTE5442 thru NTE5448 are silicon controlled rectifiers (SCR's) in a TO127 type package designed for high-volume consumer phase-control applications such as motor speed, temperature, and light controls, and for fast switching applications in ignition and starting systems, voltage regulators, vending machines, and lamp drivers.

### **Features:**

- Small, Rugged Construction
- Practical Level Triggering and Holding Characteristics @ +25°C:  
 $I_{GT} = 7\text{mA Typ}$   
 $I_{Hold} = 6\text{mA Typ}$
- Low "ON" Voltage:  $V_{TM} = 1\text{V Typ}$  @ 5A @ +25°C
- High Surge Current Rating:  $I_{TSM} = 80\text{A}$

### **Absolute Maximum Ratings:** (Note 1, $T_J = +100^\circ\text{C}$ unless otherwise specified)

Peak Repetitive Forward and Reverse Blocking Voltage (Note 2),  $V_{DRM}$  or  $V_{RRM}$

NTE5442 .....	50V
NTE5444 .....	200V
NTE5446 .....	400V
NTE5448 .....	600V

Non-Repetitive Peak Reverse Blocking Voltage ( $t = 5\text{ms}$  (max) duration),  $V_{RSM}$

NTE5442 .....	75V
NTE5444 .....	300V
NTE5446 .....	500V
NTE5448 .....	700V

RMS On-State Current (All Conduction Angles),  $I_{T(RMS)}$  ..... 8A

Average On-State Current ( $T_C = +73^\circ\text{C}$ ),  $I_{T(AV)}$  ..... 5.1A

Peak Non-Repetitive Surge Current,  $I_{TSM}$   
(1/2 cycle, 60Hz preceeded and followed by rated current and voltage) ..... 80A

Circuit Fusing ( $T_J = -40^\circ$  to  $+100^\circ\text{C}$ ,  $t = 1\text{ms}$  to  $8.3\text{ms}$ ),  $I^2t$  ..... 25A<sup>2</sup>sec

Peak Gate Power,  $P_{GM}$  ..... 5W

Average Gate Power,  $P_{G(AV)}$  ..... 500mW

Peak Forward Gate Current,  $I_{GM}$  ..... 2A

Peak Reverse Gate Voltage,  $V_{RGM}$  ..... 10V

Operating Junction Temperature Range,  $T_J$  .....  $-40^\circ$  to  $+100^\circ\text{C}$

Storage Temperature Range,  $T_{stg}$  .....  $-40^\circ$  to  $+150^\circ\text{C}$

Maximum Thermal Resistance, Junction-to-Case,  $R_{thJC}$  .....  $2.5^\circ\text{C/W}$

Typical Thermal Resistance, Junction-to-Ambient,  $R_{thJA}$  .....  $40^\circ\text{C/W}$

Note 1. **NTE5446** is a **discontinued** device and is replaced by **NTE5448**.

Note 2. Ratings apply for zero or negative gate voltage but positive gate voltage shall not be applied concurrently with a negative potential on the anode. When checking forward or reverse blocking capability, thyristor devices should not be tested with a constant current source in a manner that the voltage applied exceeds the rated blocking voltage.

**Electrical Characteristics:** ( $T_C = +25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Peak Forward or Reverse Blocking Current	$I_{\text{DRM}}, I_{\text{RRM}}$	Rated $V_{\text{DRM}}$ or $V_{\text{RRM}}$ , Gate Open	$T_J = +25^\circ\text{C}$	-	-	10 $\mu\text{A}$
			$T_J = +100^\circ\text{C}$	-	-	2 mA
Gate Trigger Current (Continuous DC)	$I_{\text{GT}}$	$V_D = 7\text{V}, R_L = 100\Omega$	$T_C = +25^\circ\text{C}$	-	7	30 mA
			$T_C = -40^\circ\text{C}$	-	-	60 mA
		$V_D = 7\text{V}, R_L = 100\Omega$	$T_C = +25^\circ\text{C}$	-	0.75	1.5 V
Gate Trigger Voltage (Continuous DC)	$V_{\text{GT}}$	$V_D = 7\text{V}, R_L = 100\Omega$	$T_C = -40^\circ\text{C}$	-	-	2.5 V
			$V_D = \text{Rated } V_{\text{DRM}}, R_L = 100\Omega, T_J = +100^\circ\text{C}$	0.2	-	- V
Peak On-State Voltage	$V_{\text{TM}}$	Pulse Width = 1ms to 2 ms, Duty Cycle $\leq 2\%$	$I_{\text{TM}} = 5\text{A}_{\text{peak}}$	-	1.0	1.5 V
			$I_{\text{TM}} = 15.7\text{A}_{\text{peak}}$	-	-	2.0 V
Holding Current	$I_{\text{Hold}}$	$V_D = 7\text{V}$ , Gate Open	$T_C = +25^\circ\text{C}$	-	6	40 mA
			$T_C = -40^\circ\text{C}$	-	-	70 mA
Gate Controlled Turn-On Time	$t_{\text{gt}}$	$I_{\text{TM}} = 5\text{A}, I_{\text{GT}} = 20\text{mA}, V_D = \text{Rated } V_{\text{DRM}}$	-	1	-	$\mu\text{s}$
Circuit Commutated Turn-Off Time	$t_q$	$I_{\text{TM}} = 5\text{A}, I_R = 5\text{A}$	$T_J = +25^\circ\text{C}$	-	15	$\mu\text{s}$
			$T_J = +100^\circ\text{C}$	-	20	$\mu\text{s}$
Critical Rate-of-Rise of Off-State Voltage	$dv/dt$	$V_D = \text{Rated } V_{\text{DRM}}$ , Exponential Waveform, $T_J = +100^\circ\text{C}$ , Gate Open	-	50	-	$\text{V}/\mu\text{s}$

